



Ref. Certif. No.

DK-72567-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

PC motherboards

Name and address of the applicant

INTEL CORPORATION
2200 MISSION COLLEGE BLVD SANTA CLARA, CA
95054-1537 USA

Name and address of the manufacturer

INTEL CORPORATION
2200 MISSION COLLEGE BLVD SANTA CLARA, CA
95054-1537 USA

Name and address of the factory

MAINTEK COMPUTER (SUZHOU) CO LTD
BLDG 6 NB 233 JIN FENG RD SUZHOU JIANGSU 215008
CHINA

Note: When more than one factory, please report on page 2

[Additional Information on page 2](#)

Ratings and principal characteristics

Electrical ratings not required
(the equipment intended for building-in, supplied by SELV)

Trademark (if any)



Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

xNUC6xAyBx, xNUC7xBNBx, xNUC7xJyBx, xNUC8xBEBx
See Page 2

Additional information (if necessary may also be reported on page 2)

[Additional Information on page 2](#)

A sample of the product was tested and found to be in conformity with

IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1, IEC 60950-1(ed.2);am2

As shown in the Test Report Ref. No. which forms part of this Certificate

ATTCB107033 issued on 2018-04-16

This CB Test Certificate is issued by the National Certification Body



- UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA
- UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK
- UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN
- UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see www.ul.com/ncbnames

Date: 2018-04-25

Signature:

Jan-Erik Storgaard



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Model Details:

xNUC6xAyBx,xNUC7xBNBx,xNUC7xJYBx,xNUC8xBEBx (where x can be a combination of alphanumeric characters, none or blank)

Factories:

GOLDEN ELITE TECHNOLOGY (SHEN ZHEN) LTD
1 NAN HUAN RD SHAJING BAO AN SHENZHEN GUANGDONG 518104
CHINA

Additional Information:

Additionally evaluated to EN 60950-1:2006 /A11:2009 /A1:2010 /A12:2011/ A2:2013.
National Difference specified in the CB Test Report

Additional information (if necessary)



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